Search Notes			

Application/Control No.	Applicant(s)/Patent unde Reexamination	r
09/869,610	GAON ET AL.	•
Examiner	Art Unit	1 44 1
Beth Van Doren	3623	

SEARCHED				
Class	Subclass	Date	Examiner	
705	8,9	9/21/2006	Ong	
			,	
			,	
		-		
			,	

TNI	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
			4
		_	
	1		

DATE	EXMR
9/21/2006	lud
9/21/2006	Owl